## Application/Control No. Applicant(s)/Patent Under Reexamination 10/044,141 PAEK, JONG SIK Notice of References Cited Art Unit Examiner Page 1 of 1 Chris C. Chu 2815 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,297,160 10-2001 Chien, Wen-Cheng 438/706 Α 257/666 В US-6,157,074 12-2000 Lee, Hyeon II US-С D US-US-Ε F US-G US-US-Н 1 US-US-J US-K US-L US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY TAKAHASHI, YOSHIKAZU H01L 21/603 JP 05206219 A 08-1993 Japan Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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**Notice of References Cited** 

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